Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/776,285	HAYASHI ET AL.	
Examiner	Art Unit	
Naghmeh Mehrpour	2686	

Naghmeh Mehrpour

SEARCHED					
Class	Subclass	Date	Examiner		
455	436	10/21/2005	NM		
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	448				
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370	331				
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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